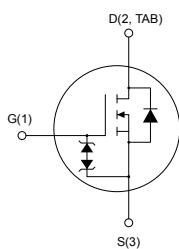


## N-channel 600 V, 345 mΩ typ., 10 A MDmesh DM6 Power MOSFET in a DPAK package

### Features


**DPAK**


AM01470v1\_tab

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STD12N60DM6	600 V	390 mΩ	10 A

- Fast-recovery body diode
- Lower R<sub>DS(on)</sub> per area vs previous generation
- Low gate charge, input capacitance and resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

### Applications

- Switching applications

### Description

This high-voltage N-channel Power MOSFET is part of the MDmesh DM6 fast-recovery diode series. Compared with the previous MDmesh fast generation, DM6 combines very low recovery charge (Q<sub>rr</sub>), recovery time (t<sub>rr</sub>) and excellent improvement in R<sub>DS(on)</sub> per area with one of the most effective switching behaviors available in the market for the most demanding high-efficiency bridge topologies and ZVS phase-shift converters.



#### Product status link

[STD12N60DM6](#)

#### Product summary

Order code	STD12N60DM6
Marking	12N60DM6
Package	DPAK
Packing	Tape and reel

## 1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate-source voltage	$\pm 25$	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	10	A
	Drain current (continuous) at $T_C = 100^\circ\text{C}$	6.3	
$I_{DM}^{(1)}$	Drain current (pulsed)	28	A
$P_{TOT}$	Total power dissipation at $T_C = 25^\circ\text{C}$	90	W
$I_{AR}^{(2)}$	Avalanche current, repetitive or not repetitive	3	A
$E_{AS}^{(3)}$	Single pulse avalanche energy	195	mJ
$dv/dt^{(4)}$	Peak diode recovery voltage slope	100	V/ns
$di/dt^{(4)}$	Peak diode recovery current slope	1000	A/ $\mu$ s
$dv/dt^{(5)}$	MOSFET dv/dt ruggedness	100	V/ns
$T_{stg}$	Storage temperature range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating junction temperature range		$^\circ\text{C}$

1. Pulse width is limited by safe operating area.
2. Pulse width limited by  $T_J$  max.
3. Starting  $T_J = 25^\circ\text{C}$ ,  $I_D = I_{AR}$ ,  $V_{DD} = 50$  V.
4.  $I_{SD} \leq 10$  A,  $V_{DS}$  (peak) <  $V_{(BR)DSS}$ ,  $V_{DD} = 400$  V.
5.  $V_{DS} \leq 480$  V.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	1.39	$^\circ\text{C}/\text{W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb	50	$^\circ\text{C}/\text{W}$

1. When mounted on an 1-inch<sup>2</sup> FR-4, 2 Oz copper board.

## 2 Electrical characteristics

( $T_C = 25^\circ\text{C}$  unless otherwise specified)

**Table 3. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	600			V
$I_{\text{DSS}}$	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}, T_C = 125^\circ\text{C}$ (1)			100	
$I_{\text{GSS}}$	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			$\pm 5$	$\mu\text{A}$
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3.25	4	4.75	V
$R_{\text{DS(on)}}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		345	390	$\text{m}\Omega$

1. Defined by design, not subject to production test.

**Table 4. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{GS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$	-	508	-	pF
$C_{oss}$	Output capacitance		-	28	-	pF
$C_{rss}$	Reverse transfer capacitance		-	4.7	-	pF
$C_{oss \text{ eq.}}^{(1)}$	Equivalent output capacitance	$V_{DS} = 0 \text{ to } 480 \text{ V}, V_{GS} = 0 \text{ V}$	-	100	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 \text{ MHz}$ open drain	-	5.8	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 480 \text{ V}, I_D = 10 \text{ A}, V_{GS} = 0 \text{ to } 10 \text{ V}$ (see Figure 14. Test circuit for gate charge behavior)	-	17	-	nC
$Q_{gs}$	Gate-source charge		-	3.8	-	nC
$Q_{gd}$	Gate-drain charge		-	9.3	-	nC

1.  $C_{oss \text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

**Table 5. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 5 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 13. Test circuit for resistive load switching times and Figure 18. Switching time waveform)	-	11	-	ns
$t_r$	Rise time		-	4.3	-	ns
$t_{d(off)}$	Turn-off delay time		-	26	-	ns
$t_f$	Fall time		-	7.3	-	ns

**Table 6. Source-drain diode**

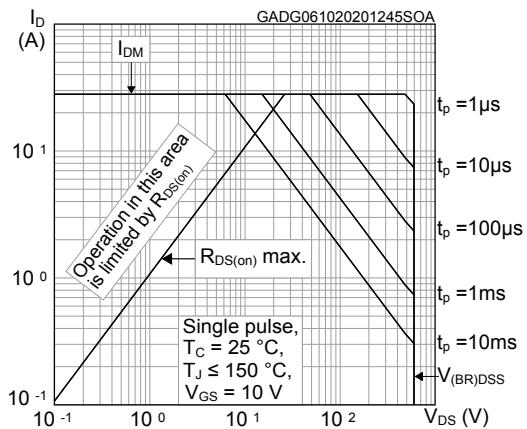
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		10	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		28	A
$V_{SD}^{(2)}$	Forward on voltage	$V_{GS} = 0 \text{ V}$ , $I_{SD} = 10 \text{ A}$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 10 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ ,	-	80		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 60 \text{ V}$ (see <a href="#">Figure 15. Test circuit for inductive load switching and diode recovery times</a> )	-	0.288		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	7.2		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 10 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ ,	-	148		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 60 \text{ V}$ , $T_J = 150 \text{ }^\circ\text{C}$ (see <a href="#">Figure 15. Test circuit for inductive load switching and diode recovery times</a> )	-	0.680		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	9.2		A

1. Pulse width is limited by safe operating area.

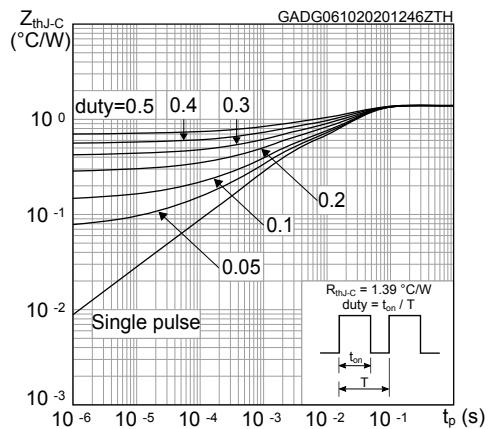
2. Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

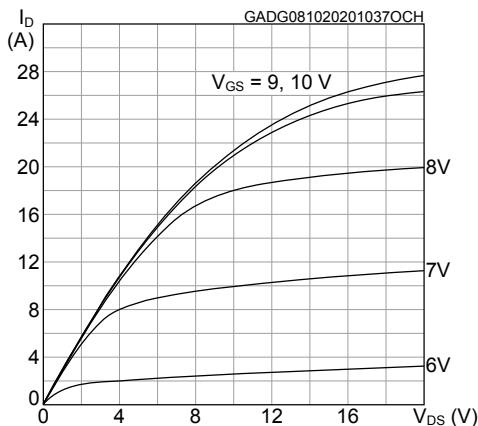
**Figure 1. Safe operating area**



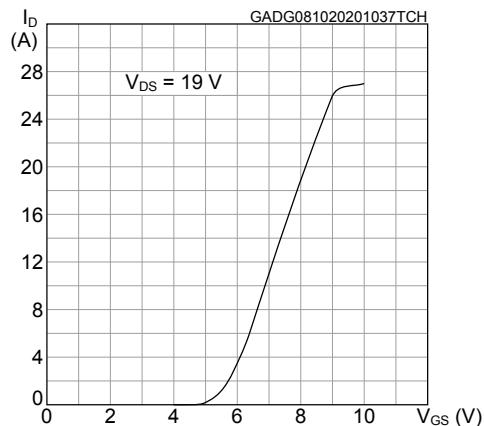
**Figure 2. Maximum transient thermal impedance**



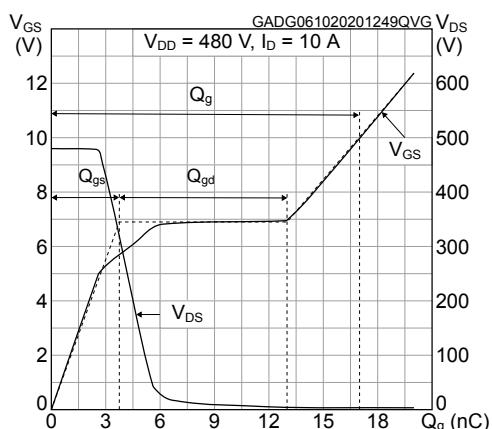
**Figure 3. Typical output characteristics**



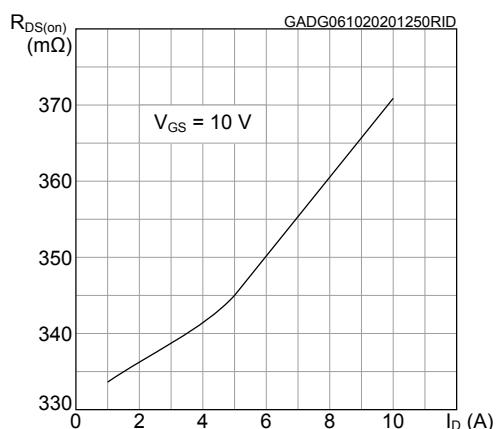
**Figure 4. Typical transfer characteristics**

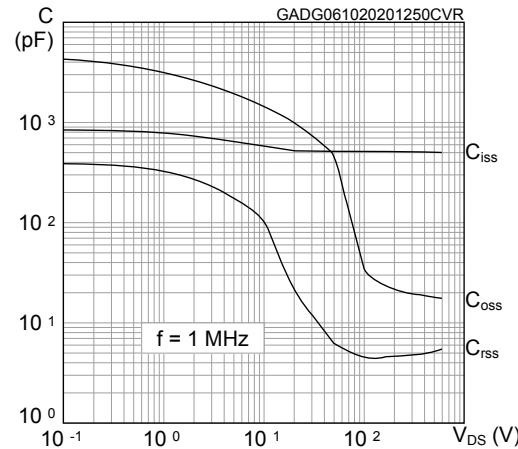
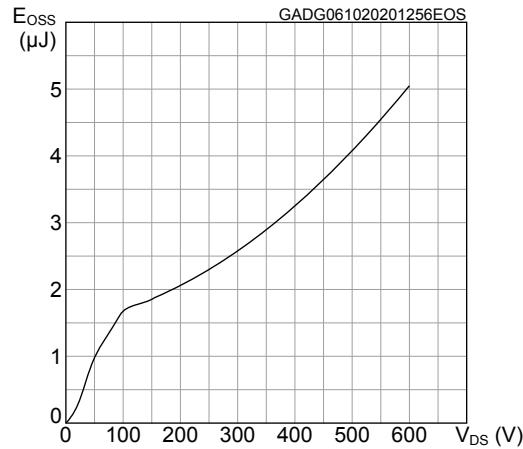
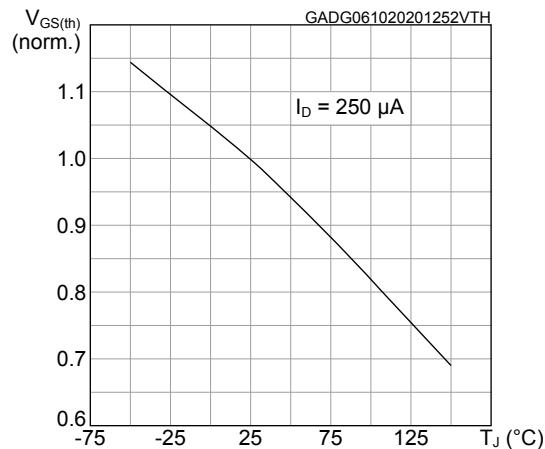
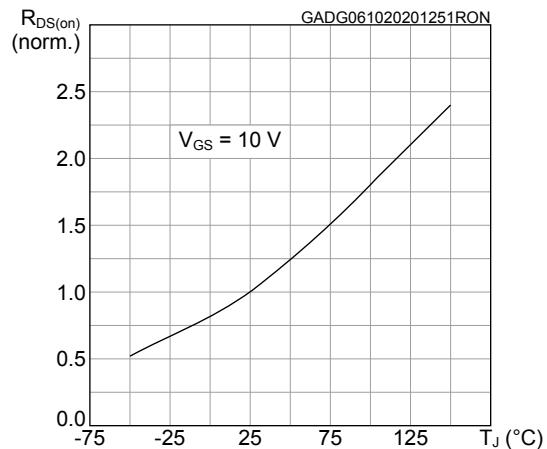
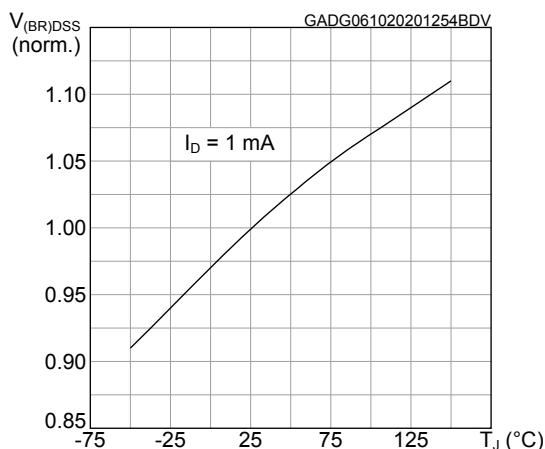
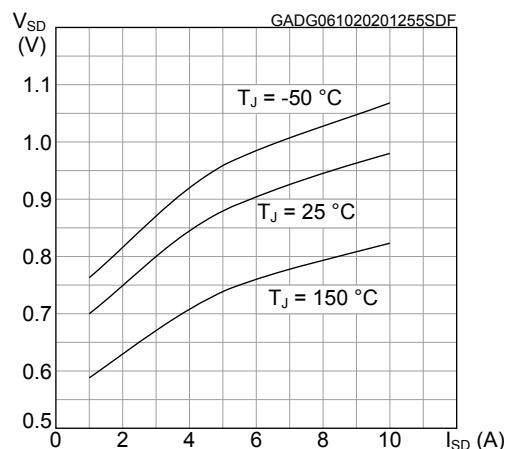


**Figure 5. Typical gate charge characteristics**



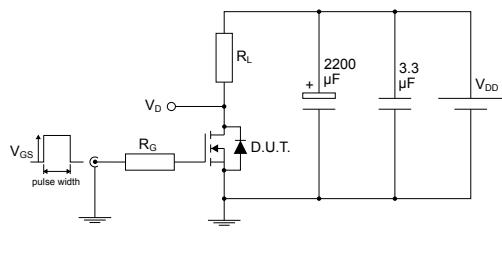
**Figure 6. Typical drain-source on-resistance**



**Figure 7. Typical capacitance characteristics**

**Figure 8. Typical output capacitance stored energy**

**Figure 9. Normalized gate threshold vs temperature**

**Figure 10. Normalized on-resistance vs temperature**

**Figure 11. Normalized breakdown voltage vs temperature**

**Figure 12. Typical reverse diode forward characteristics**


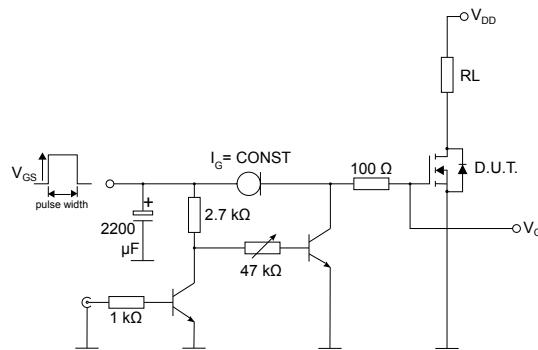
### 3 Test circuits

**Figure 13.** Test circuit for resistive load switching times



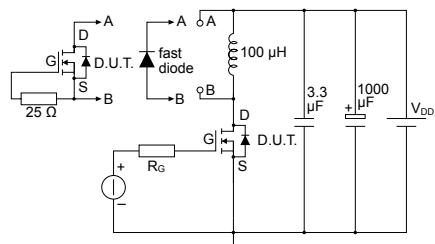
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**Figure 14.** Test circuit for gate charge behavior



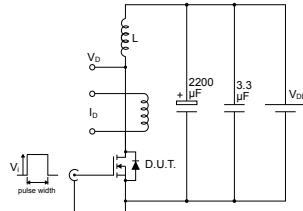
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**Figure 15.** Test circuit for inductive load switching and diode recovery times



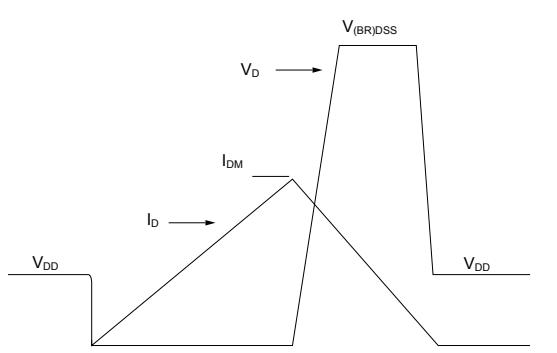
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**Figure 16.** Unclamped inductive load test circuit



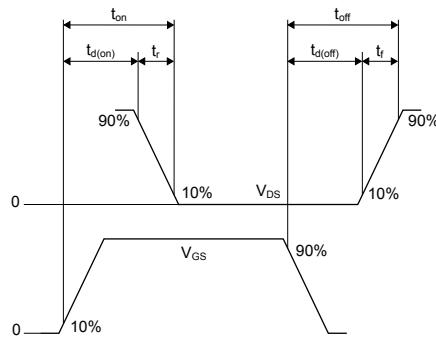
AM01471v1

**Figure 17.** Unclamped inductive waveform



AM01472v1

**Figure 18.** Switching time waveform



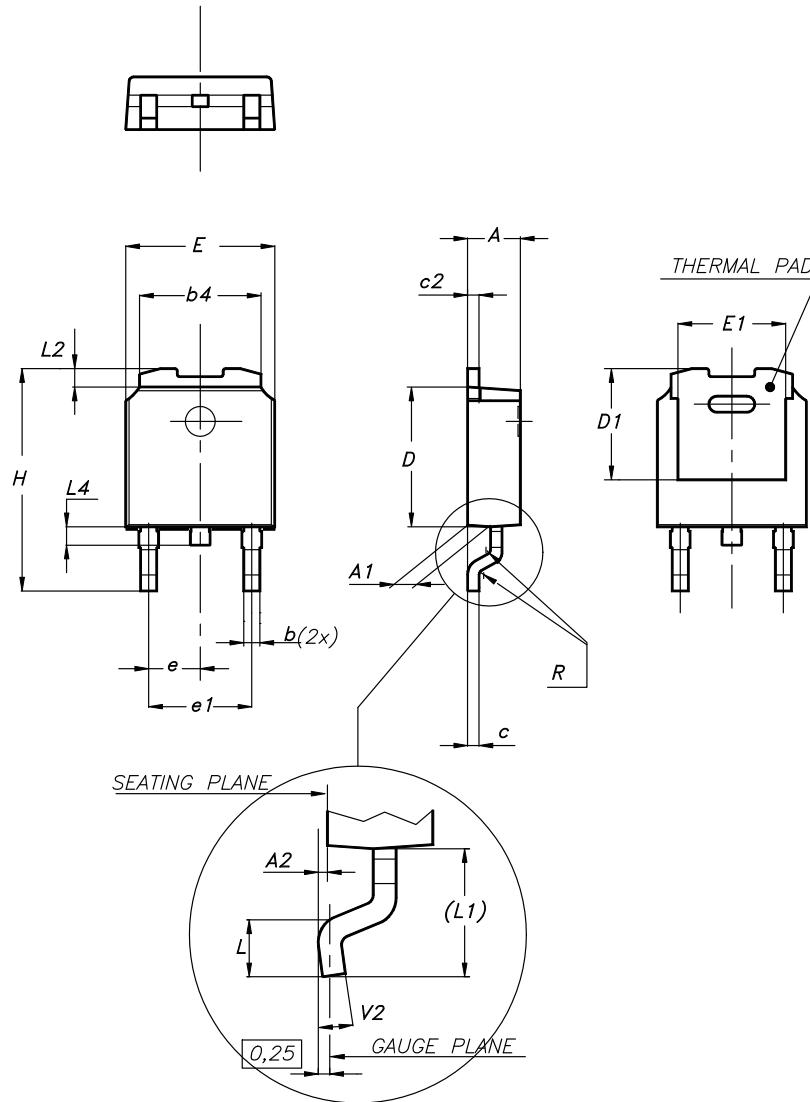
AM01473v1

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 4.1 DPAK (TO-252) type A2 package information

Figure 19. DPAK (TO-252) type A2 package outline

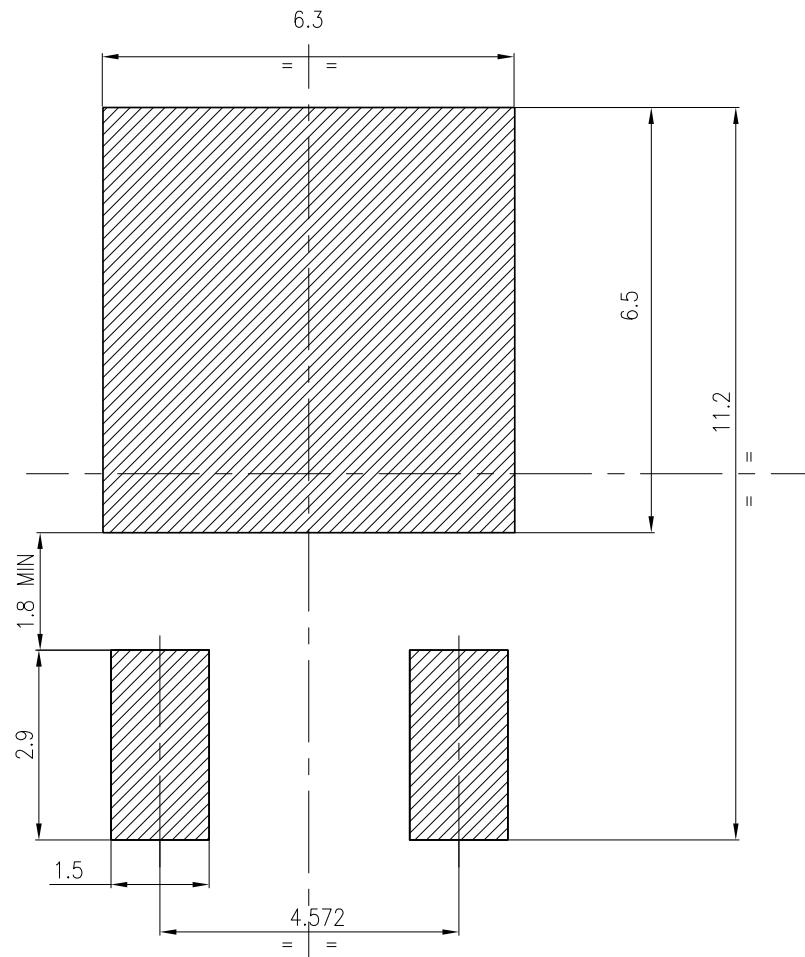


0068772\_type-A2\_rev30

**Table 7. DPAK (TO-252) type A2 mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
E	6.40		6.60
E1	5.10	5.20	5.30
e	2.159	2.286	2.413
e1	4.445	4.572	4.699
H	9.35		10.10
L	1.00		1.50
L1	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°

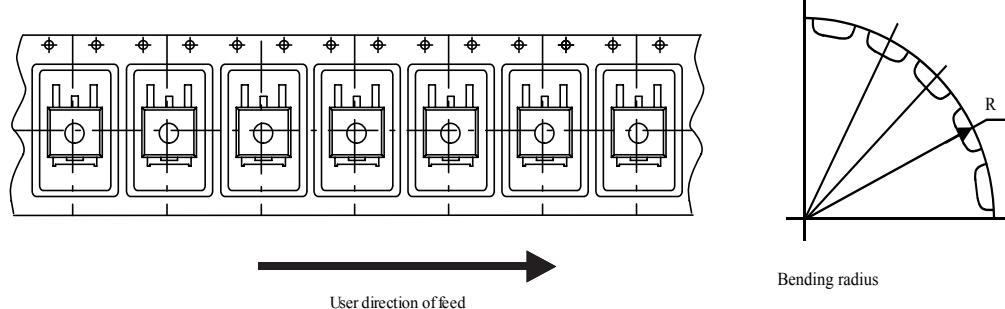
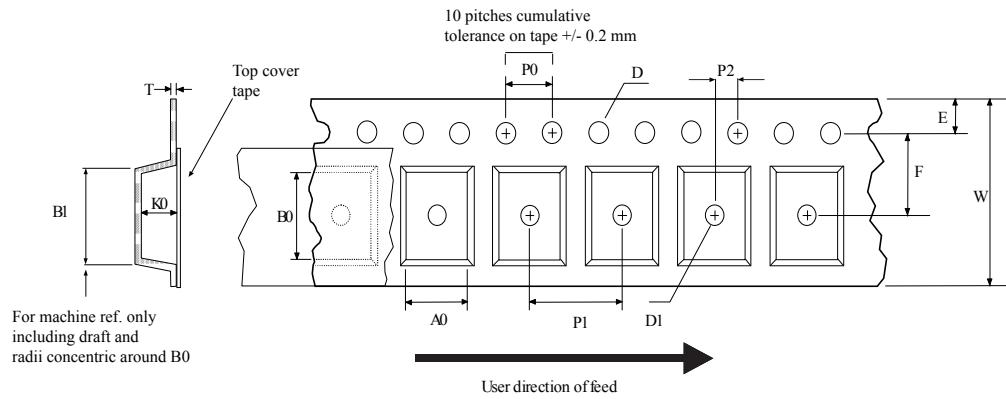
**Figure 20. DPAK (TO-252) recommended footprint (dimensions are in mm)**



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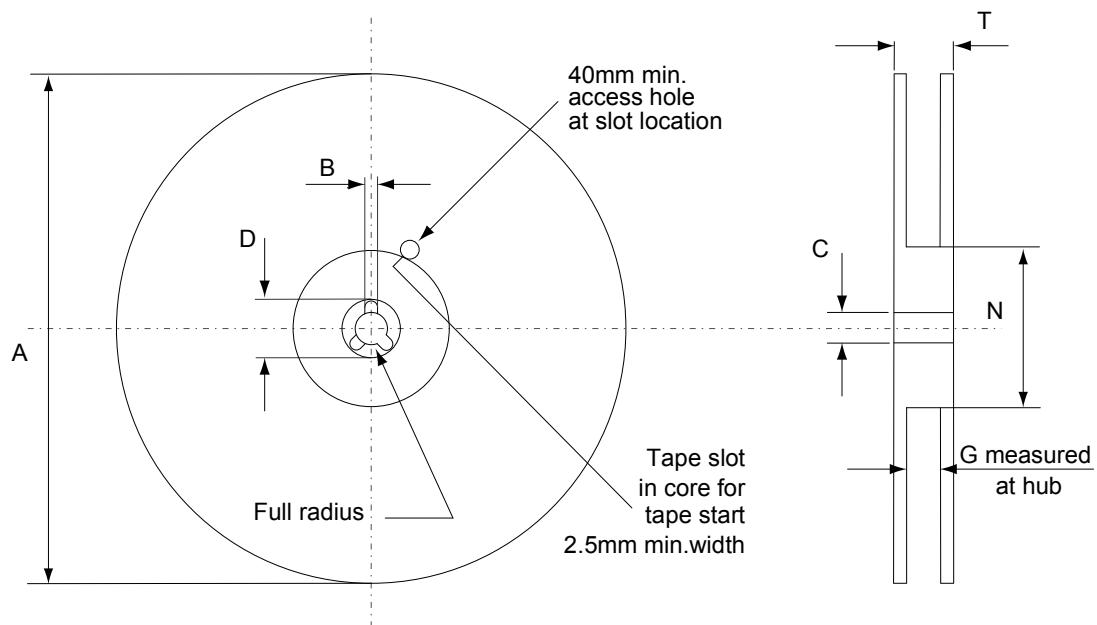
## 4.2 DPAK (TO-252) packing information

Figure 21. DPAK (TO-252) tape outline



Bending radius

AM08852v1

**Figure 22. DPAK (TO-252) reel outline**


AM06038v1

**Table 8. DPAK (TO-252) tape and reel mechanical data**

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	6.8	7	A		330
B0	10.4	10.6	B	1.5	
B1		12.1	C	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	T		22.4
K0	2.55	2.75			
P0	3.9	4.1	Base qty.		2500
P1	7.9	8.1	Bulk qty.		2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			

## Revision history

**Table 9. Document revision history**

Date	Version	Changes
09-Oct-2020	1	First release.

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